•	Issue	Classi	fication

Application/Control No. 10/785,259	Applicant(s)/Patent under Reexamination OHKAWA ET AL.
Examiner	Art Unit
B. Chen	1762

				ISSUE	CL	.AS	SIF	ICATI	ON					
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	Claims renumbered in the same order as presented by applicant									cant	☐ CPA			☐ T.D.			☐ R.1.47		
Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original
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2	3			33			63			93			123			153			183
	4			34			64			94			124			154			184
	5			35			65			95			125			155			185
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6	8			38			68]		98			128			158			188
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	22			52			82		_	112			142			172			202
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